Notice of References Cited Application/Control No. 10/823,799 Examiner Raeann Gorden Applicant(s)/Patent Under Reexamination WATANABE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0183135 A1	12-2002	Tsunoda et al.	473/332
	В	US-5,792,009 A	08-1998	Maruko, Takashi	473/359
	C	US-5,645,496 A	07-1997	Endo et al.	473/372
	D	US-2004/0053710 A1	03-2004	Lacroix et al.	473/371
	E.	US-			
	F	US-			
	G	US-			
	Ι	US-			
	ı	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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